




Search Notes 	Application/Control No. 10829325	Applicant(s)/Patent Under Reexamination YEH ET AL.
	Examiner Akanbi, Isiaka O	Art Unit 2877

Notes	Date	Examiner
East (US-PGPUB; USPAT; USOCR; EPO) See Search History Printout	2/25/2006	IOA
Consulted w/R. Rosenberger	2/24/2006	IOA
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Class	SubClass	Date	Examiner
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356	364-370, 33-35	2/25/2006	IOA

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